# Application/Control No. 09/684,463 Examiner A. Sefer Applicant(s)/Patent Under Reexamination DAUBENSPECK ET AL. Art Unit Page 1 of 1

# Notice of References Cited

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,104,079	08-0200	Stamper	257/529
	В	US-6,300,252	10-2001	Ying et al	438/723
	С	US-6,518,643	02-2003	McDevitt et al	257/529
	D	US-5,606,301	02-1997	Ishimura	337/290
	Е	US-6,372,556	04-2002	Ко	438/132
	F	US-5,731,624	03-1998	Motsiff et al	257/529
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000-12691	01-2000	Japan	Iwamoto et al	
	0					
	Р					
	Q					
	R					
	s					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	x						

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